## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination PARK ET AL. Examiner Nam V. Nguyen Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,109,222	04-1992	Welty, John	340/825.72
*	В	US-5,579,221	11-1996	Mun, Yong-Soon	700/83
*	С	US-6,169,879	01-2001	Perlman, Stephen G.	725/119
*	D	US-6,424,660	07-2002	Jacobson, Jr., James E.	370/475
*	Ε	US-6,469,633	10-2002	Wachter, Martin Richard	340/825.69
*	F <sup>·</sup>	US-6,498,567	12-2002	Grefenstette et al.	340/825.62
*	G	US-6,784,805	08-2004	Harris et al.	340/825.69
*	Н	US-6,844,807	01-2005	Inoue et al.	340/3.7
*	ı	US-7,069,345	06-2006	Shteyn, Yevgeniy Eugene	709/250
	J	US-		·	
	К	US-			
	L	US-		·	
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0		,			
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.